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**MEASUREMENT OF STABILITY OF CABLED
CONDUCTORS COOLED BY He I AT REDUCED
TEMPERATURE, OR He II**

by
**Y-H. HSU, J. R. PURCELL, W. Y. CHEN
and J. S. ALCORN**

MASTER

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GENERAL ATOMIC COMPANY

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MEASUREMENT OF STABILITY OF CABLED CONDUCTORS COOLED BY He I AT REDUCED TEMPERATURE, OR He II*

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Abstract

Stability tests of cabled NbTi alloy conductor are underway at the General Atomic High Field Test Facility, in support of the Team One effort of the DOE 12 Tesla Coil Development Program.¹ A background field of up to 10 tesla within a 20 cm bore is provided by a nested pair of 4.2 K bath cooled NbTi coils. An insulated bore insert tube (coldfinger) is provided in order to perform heat pulse/recovery tests of coiled samples in cooling regimes anticipated for the 1 m O.D. coil to be tested at the LLNL 12 tesla facility during FY 82. Specifically, tests are being performed in the 2.5–3 K He I, and saturated superfluid (He II) regimes. The testing apparatus, procedures, and initial results are presented.

Introduction

Team One (GA/MCA) of the DOE 12 Tesla Coil Development Program is now manufacturing conductor for a 0.4 m I.D. x 1 m O.D. superconducting coil, to be tested during FY 82 at the LLNL High Field (12 T) Test Facility. The cabled NbTiTa alloy, 10 kA conductor is prototypical of that envisioned for the high field region of an ETF toroidal field coil. Helium bath cooling would be employed; either He I in the 2.5–3 K range, or saturated superfluid He II at around 1.8 K.

A testing program is presently underway at General Atomic to support and augment this effort by performing heat pulse/recovery tests on coiled samples of cabled conductor in the selected cooling regimes. The goal of these tests is to guide the cryogenic design of the large test coil, and to provide a deepened understanding of the conductor/coil/coolant parameters to be encountered during the subsequent large coil tests at LLNL. The GA test apparatus and procedures are presented, as well as results of initial tests.

Experimental Arrangements

A test facility has been established at GA having the capability of generating 10 tesla within the 20 cm bore of its nested solenoid pair (Fig. 1).² Both background field coils employ NbTi; the 40 cm bore 8 tesla coil, built by MCA, is intrinsically stable, and without internal cooling; the insert coil was "dry" wound by GA using "barber pole" wrapped cable, supported by stainless steel strip wound on its O.D. Both coils are cooled by pool boiling at 4.2 K. The experiments at sub-4.2 K temperatures are performed in a separate bath within a vacuum insulated tube (coldfinger), inserted within the 20 cm bore. Figure 2 shows the experimental arrangement inside the coldfinger. A sealed insulated barrier with an opening of 5 cm is located in the coldfinger above the experimental section to prevent excessive heat leak during superfluid operation. Helium I is used to intercept the principal heat leaks, and serves as a reservoir of coolant for the experimental section. The line from the He I bath to the experimental section serves both as a fill and a liquid makeup line through a remotely actuated J-T valve. The screens (supported by phenolic sheets) are used as heat exchangers. The temperature of the bath in the experimental section is controlled by the pumping speed (pressure). Only the saturated pressure cases are presented here. The setup in the coldfinger can be modified for testing samples at subcooled conditions.

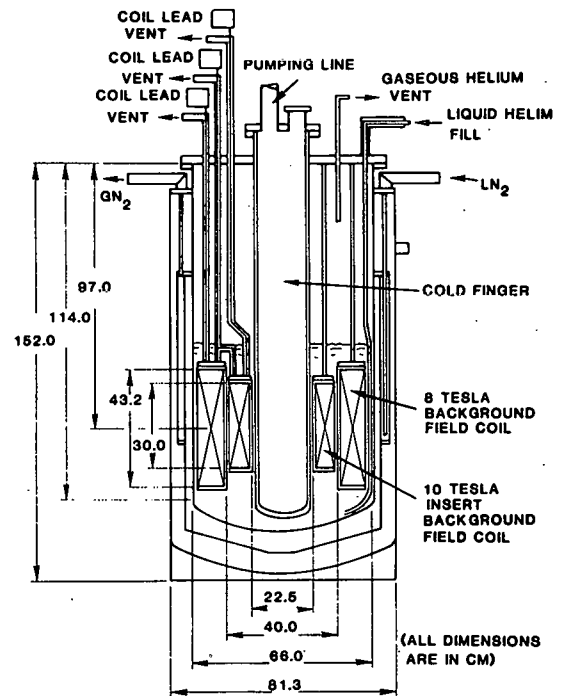


Fig. 1. Coil/cryostat cross section

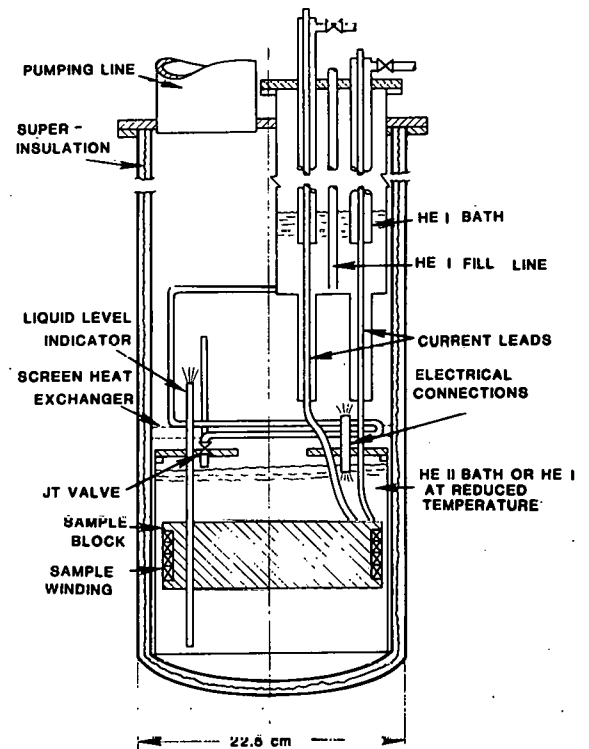


Fig. 2. Cross section of coldfinger

For the test sample shown, 85 cm of a multifilament NbTi/Cu cabled conductor from Supercon is bifilar wound as a single layer on a phenolic winding form. The conductor is insulated from adjacent conductors by a fiberglass strip; about 50% of its surface is exposed for cooling.

The heater element consists of a 10 mil diameter uninsulated nichrome wire wound around the conductor over a length of about 2.5 cm. The heater is insulated from the conductor by a layer of mylar. Additional insulation was applied over the heater element to reduce the heat flow from the heater to the helium bath. The duration of the heat pulse is controlled by the minicomputer PDP11/03. The voltage taps are uniformly spaced on the conductor. The axis of the sample is parallel to the field and is vertical.

Experimental Procedure

The test sample was placed in a constant external field and cooled by pool boiling to 4.2 K, 2.5 K or 1.8 K. For the stability test, a thermal disturbance was induced by a rectangular heat pulse and the evolution of the normal zone then monitored by observing the voltage across the various voltage taps along the conductor. The data was recorded by the computerized data acquisition system and displayed on a screen. (The recovery current was defined as the maximum current which allowed recovery of full superconductivity after the heat has been turned off.) Measurements are carried out on multifilamentary NbTi cabled conductors which are: (1) as formed; (2) solder-filled with Sn-50 Pb solder. The characteristics of the sample are listed in Table 1.

TABLE 1
CHARACTERISTICS OF THE CONDUCTOR
TESTED

Supplier.....	Supercon
Configuration	Rectangular unsoldered cable
Size	0.500 cm x 0.254 cm
Number of strands.....	18
Twist pitch	1.7 cm
Strand:	
Material	NbTi/Cu
Size	0.086 cm diameter
Number of filaments	54
Cu/Sc ratio	1.0:1
Short sample current.....	750 A at 10 T and 4.2 K

Experimental Results and Discussion

Figure 3 is a typical plot of the differential voltage as a function of time. Results of recovery current at various temperatures and fields are summarized in Table 2.

The following observations were made:

1. The recovery current at 2.5 K is lower than 4.2 K, although the critical current is higher at 2.5 K. It implies that cooling is worse at 2.5 K, i.e., the surface heat transfer is poorer at 2.5 K than at 4.2 K as expected from surface heat transfer experiments.^{3,4}
2. As anticipated, the recovery current with superfluid cooling is much larger than that with He I. Part of this improvement can be attributed to the higher critical current density; however, the largest effect is the good surface heat transfer characteristics of He II.
3. The conductor is well compacted. Taking the wetted perimeter as 30% of outer enclosure, the heat flux rate at 4.2 K is then 0.446 watt/cm². This is about half of the maximum nucleate boiling rate.

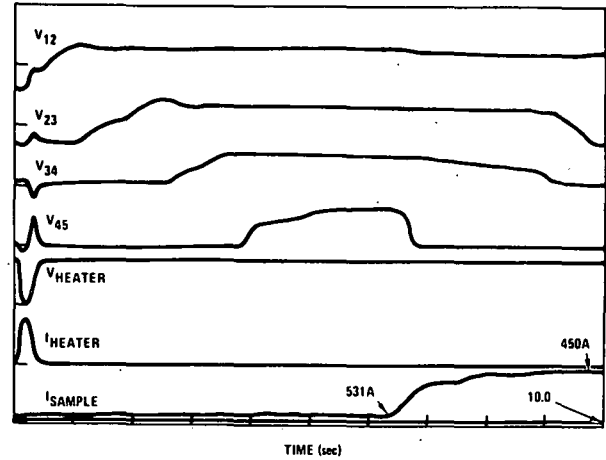


Fig. 3. Typical plot of differential voltage over the sample. The sample current was manually reduced after 6.5 seconds. (July 17, 1980, Supercon cable, 2.5 K, 8T)

TABLE 2
RECOVERY CURRENT FOR VARIOUS
TEMPERATURES AND FIELDS

No.(a)	T (K)	B (T)	E(b) (mJ)	I _{Recovery} (Amperes)	Watt(c) cm Length
1	4.2	8	2000(d)	575	0.316
1	2.5	8	2000(d)	475	0.216
1	1.89	8	2000(d)	850	0.691
1	1.8	9	2000(d)	800	0.672
2	2.0	9	2000(e)	750	0.538
2	1.77	9	1750(c)	>900	>0.775

(a) Sample No. 1 is cabled conductor as formed.

Sample No. 2 is solder-filled cabled conductor.

(b) Disturbance energy.

(c) Heat generation rate in the normal region, assuming uniform current distribution.

(d) Heat pulse duration = 0.2 sec.

(e) Heat pulse duration = 1.0 sec.

4. All the operating currents in the sample are well below the critical current. The normal zone propagation velocities are in the few cm/sec range.
5. For the solder-filled sample, we encountered a shorted heater, so the experimental data only gives qualitative behavior. It does show that the recovery current is smaller than the cabled conductor under the same condition, but is larger than that at 4.2 K.
6. The double step behavior of differential voltage, as mentioned by S.W. Van Sciver and O. Christianson,⁵ was sometimes seen in our data.

Further investigation is necessary.

Conclusions

Tests performed to date emphasize the relative ease of operating with saturated superfluid helium. Preliminary heat pulse/recovery tests confirm the greatly improved conductor stability performance in the He II regime, relative to operation at 2.5–3 K. Both results point to the desirability of seriously considering employment of NbTiTa alloy, bath cooled with saturated superfluid helium for large coil applications.

Further samples are being prepared for systematic quantitative study of cabled NbTi alloy conductor, bath cooled with He I in the 2.5–3 K range, and with saturated superfluid helium.

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